

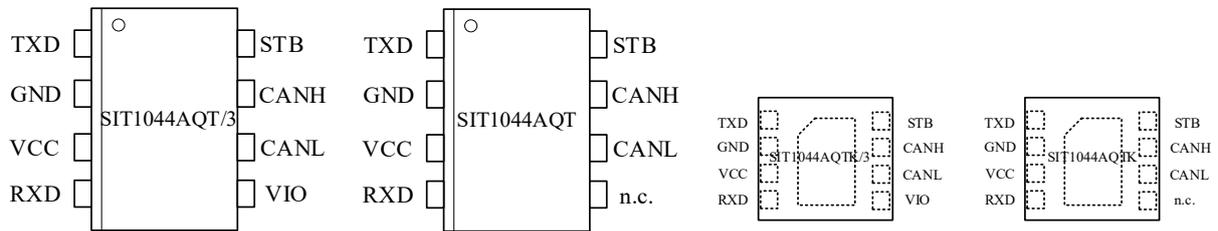
FEATURES

- ISO 11898-2:2024, SAE J2284-1~ SAE J2284-5 and SAE J1939-14 compliant;
- Thermally protected;
- $\pm 42\text{V}$ BUS protection;
- Driver (TXD) dominant time-out function;
- Low power Standby mode with remote and local wake-up capability;
- SIT1044AQ/3 I/O pins support 1.8V, 3.3V and 5V MCU;
- Undervoltage protection on pins VCC and VIO;
- High-speed CAN, support 8Mbps CAN with Flexible Data-Rate;
- High ElectroMagnetic Immunity;
- Unpowered state disengages from the bus;
- Available in SOP8 and leadless DFN3*3-8 packages; DFN3*3-8 with improved Automated Optical Inspection (AOI) capability

DESCRIPTION

The SIT1044AQ is an interface chip designed for use between CAN protocol controllers and the physical bus, applicable in automotive and industrial control fields. It supports Flexible Data-Rate of up to 8Mbps and features differential signal transmission capability between the bus and the CAN protocol controller.

Parameter	Symbol	Min	Max	Unit
VCC supply voltage	VCC	4.5	5.5	V
VIO supply voltage	VIO	1.7	5.5	V
CANH, CANL input / output voltage	V _{can}	-42	+42	V
Bus differential voltage	V _{diff}	1.5	3.0	V
Ambient temperature	T _{amb}	-40	125	°C
Storage temperature	T _{stg}	-55	150	°C

PIN CONFIGURATION

PIN DESCRIPTION

Pin	Symbol	Description
1	TXD	Transmit data input.
2	GND	Ground.
3	VCC	5V supply voltage input.
4	RXD	Receive data output.
5	VIO	Supply voltage input for I/O level adapter in SIT1044AQ/3.
	n.c.	Not connected in SIT1044AQ.
6	CANL	LOW-level CAN bus line.
7	CANH	HIGH-level CAN bus line.
8	STB	Standby mode control input.

Note: The metal pad on the back of the DFN3*3-8 package is recommended to be grounded.

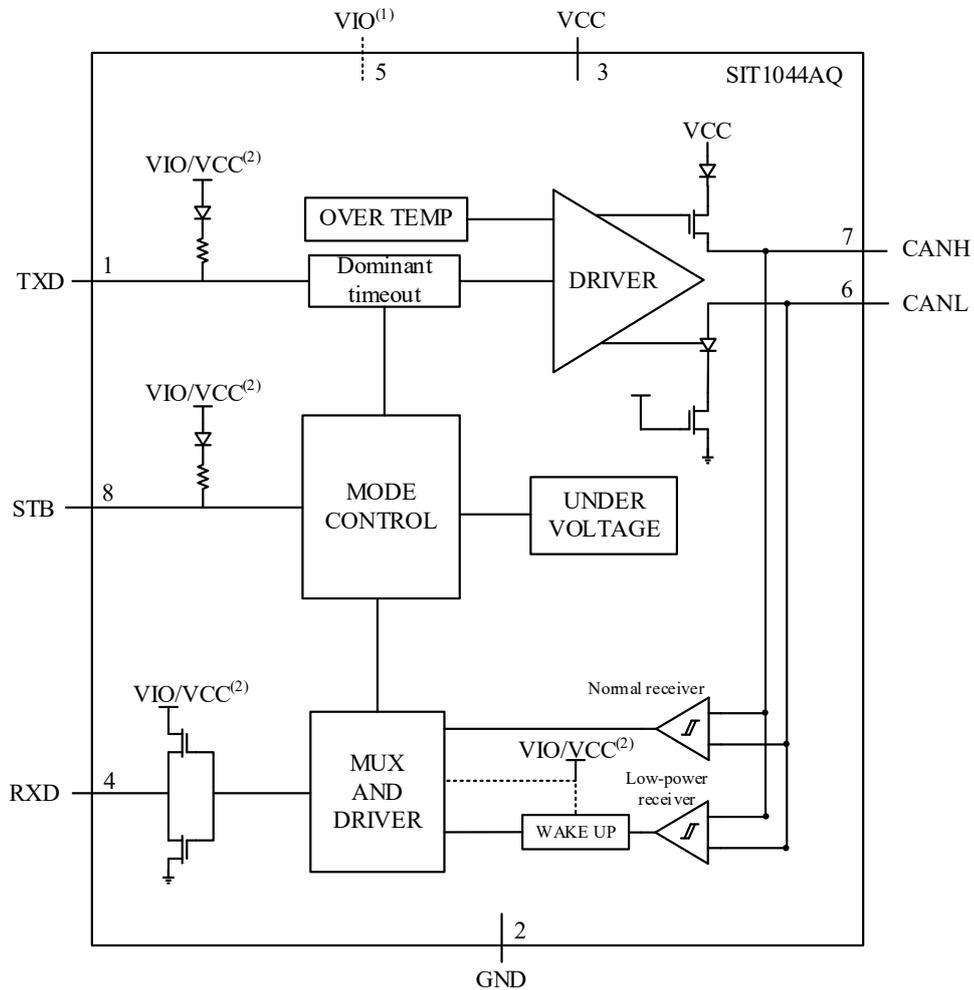
LIMITING VALUES

Parameter	Symbol	Conditions	Value	Unit	
Supply voltage	V_{CC}, V_{VIO}	pins VCC, VIO	-0.3~+7	V	
MCU side ports voltage	$V_{TXD}, V_{RXD}, V_{STB}$	pins TXD, RXD, STB	-0.3~+7	V	
Voltage between pin CANH and pin CANL	V_{CANL}, V_{CANH}	pins CANH, CANL	-42~+42	V	
Bus differential voltage withstand	$V_{CANH-CANL}$		-42~+42	V	
electrostatic discharge voltage	V_{ESD}	IEC 61000-4-2: on pins CANH, CANL	-10~+10	kV	
		Human-body model (HBM), per AEC Q100-002			
		all pins	-4~+4	kV	
		pins CANH and CANL with respect to GND	-8~+8	kV	
		Charged Device Model (CDM)			
		on corner pins	-750~+750	V	
		on any other pin	-500~+500	V	
transient voltage	V_{trt}	Transient Immunity ISO 7637-2 on Bus Pins			
		pulse 1	-100	V	
		pulse 2a	75	V	
		pulse 3a	-150	V	
		pulse 3b	100	V	
Storage temperature	T_{stg}		-55~150	°C	
Virtual junction temperature	T_j		-40~150	°C	

The maximum limit parameters mean that exceeding these values may cause irreversible damage to the device. Under these conditions, it is not conducive to the normal operation of the device. The continuous operation of the device at the maximum allowable rating may affect the reliability of the device. The reference point for all voltages is ground.

THERMAL CHARACTERISTICS

Symbol	Parameter	Conditions	Value	Unit
$R_{\theta JA}$	Junction-to-ambient thermal resistance	SOP8	95	°C/W
		DFN3*3-8	65	°C/W
$R_{\theta JC}$	Junction-to-case thermal resistance	SOP8	46	°C/W
		DFN3*3-8	35	°C/W

BLOCK DIAGRAM


(1) VIO is only available in the SIT1044AQ/3, pin 5 is not connected in the SIT1044AQ;

(2) VIO in SIT1044AQ/3; VCC in SIT1044AQ.

STATIC CHARACTERISTICS

Unless specified otherwise; all values are tested in recommended operating conditions: $T_j = -40^{\circ}\text{C} \sim 150^{\circ}\text{C}$, $V_{CC} = 4.5\text{V} \sim 5.5\text{V}$, $V_{IO} = 1.7\text{V} \sim 5.5\text{V}$ (SIT1044AQ/3), $R_L = 60\Omega$.

Parameter	Symbol	Condition	Min.	Typ.	Max.	Unit
Supply characteristics: pin VCC						
Supply voltage	V_{CC}		4.5	-	5.5	V
Standby undervoltage detection voltage	$V_{uvd(stb)}$		3.4	-	4.5	V
Standby undervoltage hysteresis voltage	$V_{uvhys(stb)}$		50	-	-	mV
Switch-off undervoltage detection voltage	$V_{uvd(swoff)}$	SIT1044AQ	0.95	-	1.65	V
VCC supply current	I_{CC}	Normal mode; dominant; $t < t_{to(dom)TXD}$; $V_{TXD} = 0\text{V}$	-	40	70	mA
		Normal mode; dominant; short circuit on bus lines; $V_{TXD} = 0\text{V}$; $-3\text{V} < (V_{CANH} = V_{CANL}) < +40\text{V}$	-	-	125	mA
		Normal mode; recessive; $V_{TXD} = V_{IO}^{(1)}$	-	4.2	10	mA
		Standby mode; SIT1044AQ/3	-	-	2	μA
		Standby mode; SIT1044AQ	-	-	21	μA
I/O level adapter supply; pin VIO (SIT1044AQ/3)						
Supply voltage	V_{IO}		1.7		5.5	V
Switch-off undervoltage detection voltage	$V_{uvd(swoff)}$		0.95		1.65	V
VIO supply current	I_{IO}	Normal mode; dominant; $V_{TXD} = 0\text{V}$		240	760	μA
		Normal mode; recessive; $V_{TXD} = V_{IO}^{(1)}$		120	460	μA
		Standby mode			21	μA
Pin TXD characteristics						
HIGH-level input voltage	V_{IH}		$0.7 V_{IO}^{(1)}$	-	-	V
LOW-level input voltage	V_{IL}		-	-	$0.3 V_{IO}^{(1)}$	V
Hysteresis voltage	$V_{hys(TXD)}$		50	-	-	mV
Pull-up resistance	R_{pu}		20	-	80	$\text{k}\Omega$
Input capacitance	$C_i^{(2)}$		-	-	10	pF
Pin RXD characteristics						
HIGH-level output current	$I_{OH(RXD)}$	$V_{RXD} = V_{IO} - 0.4\text{V}^{(1)}$	-10	-	-1	mA
LOW-level output current	$I_{OL(RXD)}$	Bus dominant; $V_{RXD} = 0.4\text{V}$	1	-	10	mA
Pin STB characteristics						
HIGH-level input voltage	V_{IH}		$0.7 V_{IO}^{(1)}$	-	-	V

Parameter	Symbol	Condition	Min.	Typ.	Max.	Unit
LOW-level input voltage	V_{IL}		-	-	$0.3V_{IO}^{(1)}$	V
Hysteresis voltage	$V_{hys(STB)}$		50	-	-	mV
Pull-up resistance	R_{pu}		20	-	80	k Ω
Input capacitance	$C_i^{(2)}$		-	-	10	pF
Overtemperature protection						
Shutdown junction temperature	$T_{j(sd)}$		165	-	185	$^{\circ}C$
Release shutdown junction temperature	$T_{j(sd)rel}$		155	-	175	$^{\circ}C$
Bus lines; pins CANH and CANL						
Dominant output voltage on pin CANH	$V_{O(dom)}$	$t < t_{to(dom)TXD}$; $V_{TXD}=0V$; $R_L=50\Omega$ to 65Ω	2.89	3.55	4.26	V
Dominant output voltage on pin CANL			0.77	1.45	2.13	V
Transmitter voltage symmetry	V_{TXsym}	$V_{TXsym}=V_{CANH}+V_{CANL}$; $C_{SPLIT}=4.7nF$; $f_{TXD}=250kHz, 1MHz$ or $2.5MHz$	$0.9V_{CC}$	-	$1.1V_{CC}$	V
Common mode voltage step	$V_{cm(step)}$	(2)	-150	-	150	mV
Peak-to-peak common mode voltage	$V_{cm(p-p)}$	(2)	-300	-	300	mV
Differential output voltage	$V_{O(diff)}$	Normal mode; $t < t_{to(dom)TXD}$; $V_{TXD}=0V$; $V_{CC}=4.5V$ to $5.5V$; $R_L=50\Omega$ to 65Ω	1.5	-	3	V
		Normal mode; $t < t_{to(dom)TXD}$; $V_{TXD}=0V$; $V_{CC}=4.5V$ to $5.5V$; $R_L=45\Omega$ to 70Ω	1.4	-	3.3	V
		Normal mode; dominant; $t < t_{to(dom)TXD}$; $V_{TXD}=0V$; $V_{CC}=4.5V$ to $5.5V$; $R_L=2240\Omega$	1.5	-	5	V
		Normal mode; $V_{TXD}=V_{IO}$; ⁽¹⁾ No load	-500	-	+50	mV
		Standby mode; recessive; No load	-0.2	-	+0.2	V
Output voltage	$V_{O(rec)}$	Normal mode; $V_{TXD}=V_{IO}$; ⁽¹⁾ No load	2	2.5	3	V
		Standby mode; $V_{TXD}=V_{IO}$; ⁽¹⁾ No load	-0.1	-	+0.1	V
Differential receiver threshold voltage	$V_{th(RX)diff}$	Normal mode; $-12V \leq V_{CANH} \leq 12V$; $-12V \leq V_{CANL} \leq 12V$	0.5	-	0.9	V
		Standby mode; $-12V \leq V_{CANH} \leq 12V$; $-12V \leq V_{CANL} \leq 12V$	0.4	-	1.1	V
Receiver recessive voltage	$V_{rec(RX)}$	Normal mode; $-12V \leq V_{CANH} \leq 12V$; $-12V \leq V_{CANL} \leq 12V$	-4	-	0.5	V
		Standby mode; $-12V \leq V_{CANH} \leq 12V$; $-12V \leq V_{CANL} \leq 12V$	-4	-	0.4	V
Receiver dominant voltage	$V_{dom(RX)}$	Normal mode; $-12V \leq V_{CANH} \leq 12V$; $-12V \leq V_{CANL} \leq 12V$	0.9	-	9	V

Parameter	Symbol	Condition	Min.	Typ.	Max.	Unit
		Standby mode; -12V ≤ V _{CANH} ≤ 12V; -12V ≤ V _{CANL} ≤ 12V	1.1	-	9	V
Differential receiver hysteresis voltage	V _{hys(RX)dif}	Normal mode; -12V ≤ V _{CANH} ≤ 12V; -12V ≤ V _{CANL} ≤ 12V	80	-	-	mV
Short-circuit output current	I _{O(SC)}	V _{CANH} = -15V to 40V; V _{CANL} = -15V to 40V		-	115	mA
Recessive short-circuit output current	I _{O(SC)rec}	V _{CANH} = -27V to 32V; V _{CANL} = -27V to 32V; V _{TXD} = V _{IO} for t > t _{d(TXD-busrec)end}	-5		5	mA
Leakage current	I _L	V _{CC} = V _{IO} = 0V or pins shorted to GND via 47kΩ; V _{CANH} = V _{CANL} = 5V	-10		10	μA
Input resistance	R _i	-2V ≤ V _{CANH} ≤ 7V; -2V ≤ V _{CANL} ≤ 7V	25	40	50	kΩ
Input resistance deviation	ΔR _i	0V ≤ V _{CANH} ≤ 5V; 0V ≤ V _{CANL} ≤ 5V	-2		2	%
Differential input resistance	R _{ID}	-2V ≤ V _{CANH} ≤ 7V; -2V ≤ V _{CANL} ≤ 7V	50	80	100	kΩ
Common-mode input capacitance	C _{i(cm)} ⁽²⁾		-	-	40	pF
Differential input capacitance	C _{i(dif)} ⁽²⁾		-	-	20	pF

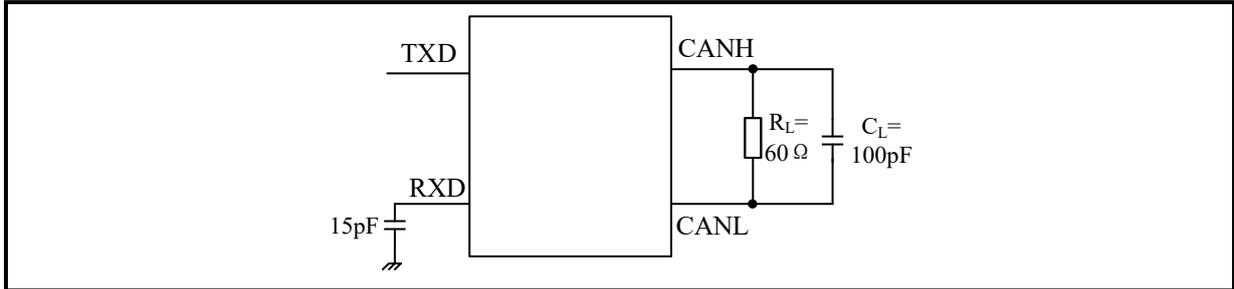
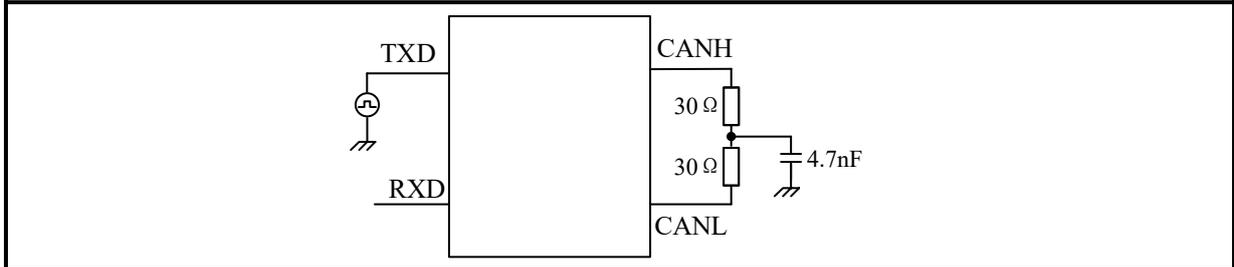
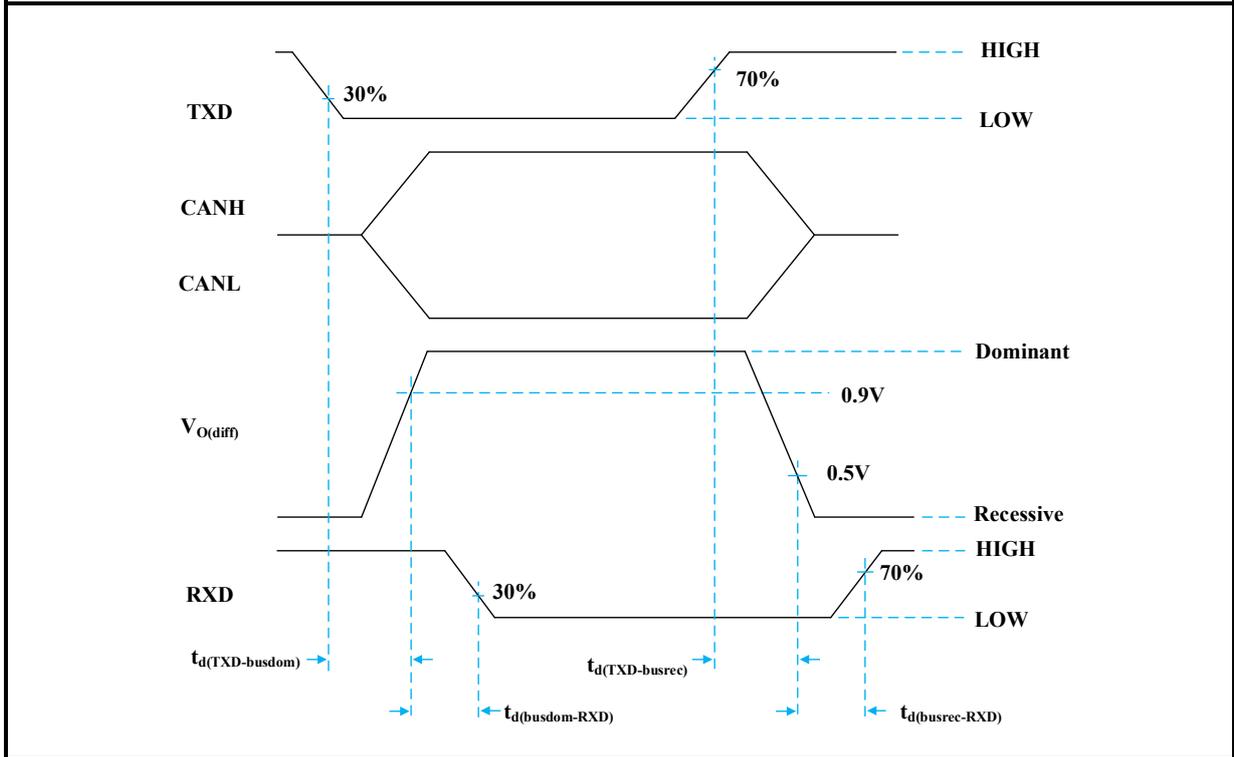
DYNAMIC CHARACTERISTICS

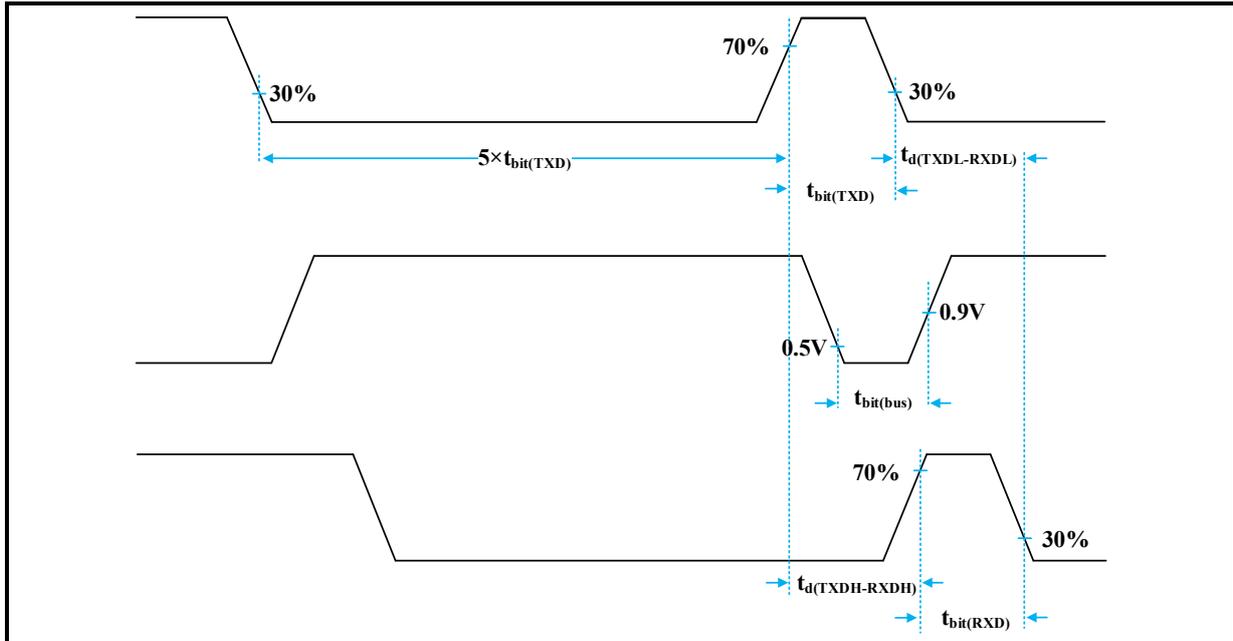
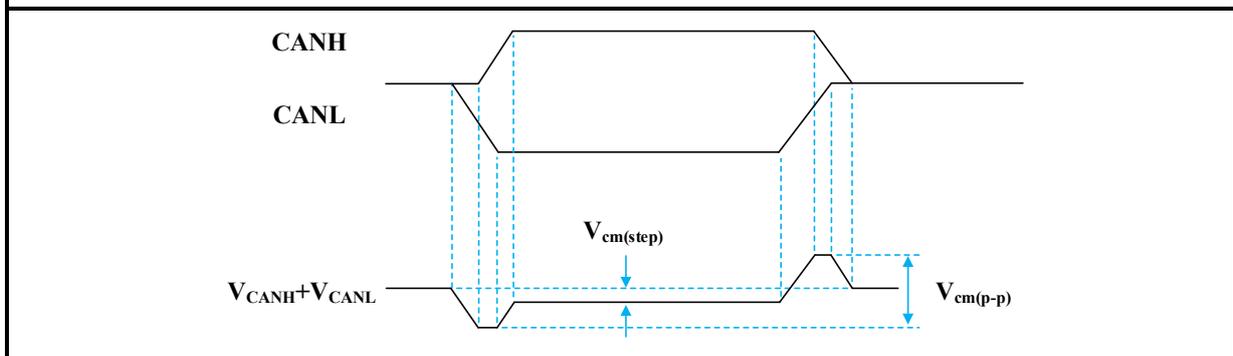
Unless specified otherwise; all values are tested in recommended operating conditions: $T_j = -40^{\circ}\text{C} \sim 150^{\circ}\text{C}$, $V_{CC} = 4.5\text{V} \sim 5.5\text{V}$, $V_{IO} = 1.7\text{V} \sim 5.5\text{V}$ (SIT1044AQ/3), $R_L = 60\Omega$.

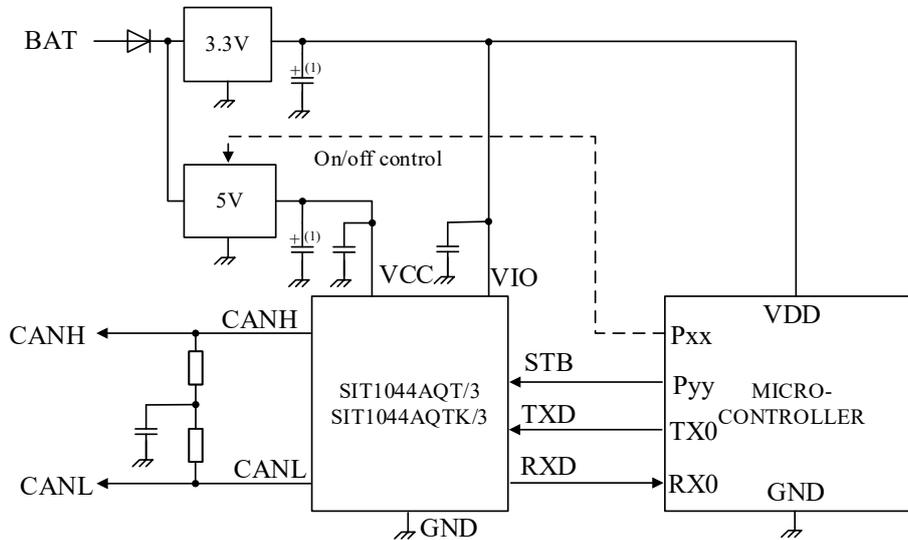
Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
CAN timing characteristics; $t_{\text{bit(TXD)}} \geq 125\text{ns}$; Figure 1 and Figure 3.						
Delay time from TXD to bus dominant	$t_{\text{d(TXD-busdom)}}^{(2)}$	Normal mode	-	-	80	ns
Delay time from TXD to bus recessive	$t_{\text{d(TXD-busrec)}}^{(2)}$	Normal mode	-	-	80	ns
Delay time from bus dominant to RXD	$t_{\text{d(busdom-RXD)}}^{(2)}$	Normal mode	-	-	110	ns
Delay time from bus recessive to RXD	$t_{\text{d(busrec-RXD)}}^{(2)}$	Normal mode	-	-	110	ns
Delay time from TXD LOW to RXD LOW	$t_{\text{d(TXDL-RXDL)}}^{(2)}$	Normal mode	-	-	190	ns
Delay time from TXD HIGH to RXD HIGH	$t_{\text{d(TXDH-RXDH)}}^{(2)}$	Normal mode	-	-	190	ns
CAN FD timing characteristics; Figure 1 and Figure 4.						
Transmitted recessive bit width	$t_{\text{bit(bus)}}^{(2)}$	2Mbit/s ($t_{\text{bit(TXD)}} = 500\text{ns}$)	480	-	520	ns
		5Mbit/s ($t_{\text{bit(TXD)}} = 200\text{ns}$)	180	-	220	ns
		8Mbit/s ($t_{\text{bit(TXD)}} = 125\text{ns}$)	115	-	135	ns
Bit time on pin RXD	$t_{\text{bit(RXD)}}^{(2)}$	2Mbit/s ($t_{\text{bit(TXD)}} = 500\text{ns}$)	470	-	520	ns
		5Mbit/s ($t_{\text{bit(TXD)}} = 200\text{ns}$)	170	-	220	ns
		8Mbit/s ($t_{\text{bit(TXD)}} = 125\text{ns}$)	95	-	145	ns
Transmitted recessive bit width deviation	$\Delta t_{\text{bit(bus)}}^{(2)}$	$\Delta t_{\text{bit(bus)}} = t_{\text{bit(bus)}} - t_{\text{bit(TXD)}}$	-10	-	10	ns
Receiver timing symmetry	$\Delta t_{\text{rec}}^{(2)}$	$\Delta t_{\text{rec}} = t_{\text{bit(RXD)}} - t_{\text{bit(bus)}}$	-20	-	15	ns
Received recessive bit width deviation	$\Delta t_{\text{bit(RXD)}}^{(2)}$	$\Delta t_{\text{bit(RXD)}} = t_{\text{bit(RXD)}} - t_{\text{bit(TXD)}}$	-30	-	20	ns
TXD dominant time-out time						
TXD dominant time-out time	$t_{\text{to(dom)TXD}}^{(2)}$	$V_{\text{TXD}} = 0\text{V}$; Normal mode	0.8	-	9	ms
Bus wake-up times; pins CANH and CANL; Figure 11.						
Bus dominant wake-up filter time	$t_{\text{fitr_wake(busdom)}}$	Standby mode	0.5	-	1.8	μs
Bus recessive wake-up filter time	$t_{\text{fitr_wake(busrec)}}$	Standby mode	0.5	-	1.8	μs
Bus wake-up time-out time	$t_{\text{to(wake)bus}}$	Standby mode	0.8	-	9	ms
Mode transitions						
Mode change transition time	$t_{\text{(moch)}}$		-	-	50	μs

(1) V_{IO} only in SIT1044Q/3 version.

(2) Guaranteed by design; not tested in production.

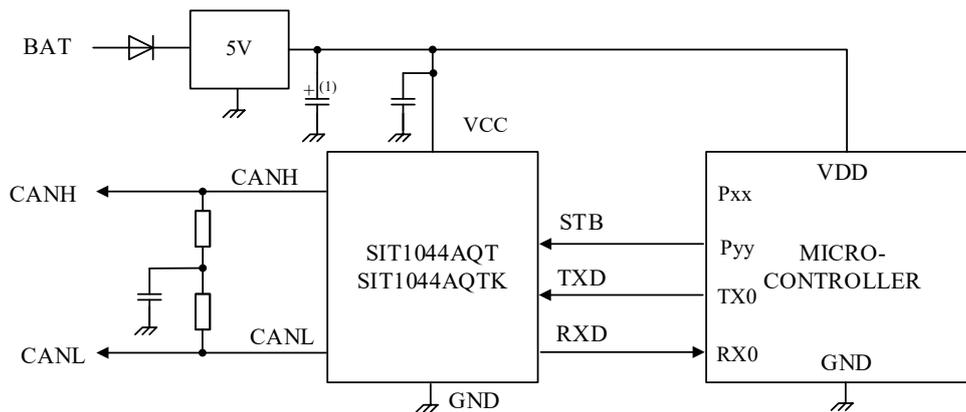
TEST CIRCUIT

Figure 1 CAN transceiver timing test circuit

Figure 2 Test circuit for measuring transceiver driver symmetry

Figure 3 CAN transceiver timing diagram


Figure 4 CAN FD timing definitions according to ISO 11898-2:2024

Figure 5 CAN bus common-mode voltage according to SAE 1939-14

APPLICATION INFORMATION


(1) Optional, depends on regulator.

Figure 6 Typical SIT1462Q/3 application with a 3.3V microcontroller



(1) Optional, depends on regulator.

Figure 7 Typical SIT1462Q application with a 5V microcontroller

ADDITIONAL DESCRIPTION
1 Sketch

The SIT1044AQ is an interface chip designed for use between CAN protocol controllers and the physical bus, applicable in automotive and industrial control fields. It supports Flexible Data-Rate of up to 8Mbps and features differential signal transmission capability between the bus and the CAN protocol controller.

2 Overtemperature protection

The device is protected against overtemperature conditions. If the junction temperature exceeds the shutdown junction temperature, $T_{j(sd)}$, the CAN bus drivers are disabled. When the junction temperature drops below $T_{j(sd)rel}$, the CAN bus drivers recover once TXD has been reset to HIGH and Normal mode is selected (waiting for TXD to go HIGH prevents output driver oscillation due to small variations in temperature).

3 Undervoltage protection

If VCC drops below the standby undervoltage detection threshold ($V_{uvd(stb)}(VCC)$) for $t_{det(uv)}$, the transceiver switches to Standby mode. The logic state of pin STB is ignored until VCC has recovered.

In the SIT1044AQ/3, if VIO drops below the switch-off undervoltage detection threshold ($V_{uvd(swoff)}(VIO)$) for $t_{uvd(swoff)}$, the transceiver switches to Off mode and disengages from the bus (high-ohmic) until VIO has recovered.

In the SIT1044AQ, if VCC drops below the switch-off undervoltage detection threshold ($V_{uvd(swoff)}(VCC)$) for $t_{uvd(swoff)}$, the transceiver switches to Off mode and disengages from the bus (high-ohmic) until VCC has recovered.

4 Operating modes

SIT1044AQ supports three operating modes, Normal, Standby and Off. The operating mode is selected via pin STB. The following table shows the corresponding mode status.

Mode	Inputs		Outputs	
	STB	TXD	CAN driver	RXD
Normal	LOW	LOW	Dominant	LOW
		HIGH	Recessive	LOW when bus dominant HIGH when bus recessive
Standby	HIGH	X	Biased to ground	Follows BUS when wake-up detected HIGH when no wake-up detected
Off ⁽¹⁾	X	X	High-ohmic state	High-ohmic state

(1) Off mode is entered when the voltage on pin VIO or pin VCC is below the switch-off undervoltage detection threshold.

4.1 Off mode

The SIT1044AQ switches to Off mode from any mode when the supply voltage falls below the switch-off undervoltage threshold $V_{uvd(swoff)}$.

In Off mode, the pins CAN and RXD are in a high-ohmic state.

4.2 Standby mode

When the supply voltage rises above the switch-off undervoltage detection threshold, the SIT1044AQ starts to boot up, triggering an initialization procedure. The SIT1044AQ switches to the selected mode after t_{startup} . Standby mode is selected when pin STB goes HIGH. In this mode, the transceiver is unable to transmit or receive data and a low-power receiver is activated to monitor the bus for a wake-up pattern. The transmitter and Normal-mode receiver blocks are switched off and the bus pins are biased to ground to minimize system supply current. Pin RXD follows the bus after a wake-up request has been detected.

A transition to Normal mode is triggered when STB is forced LOW.

If the supply voltage is below the Standby undervoltage hysteresis voltage $V_{\text{uvd(stb)}}$ when STB goes LOW, the SIT1044AQ will remain in Standby mode.

Pending wake-up events will be cleared and differential data on the bus pins converted to digital data via the low-power receiver and output on pin RXD.

In the SIT1044AQ/3, the low-power receiver is supplied from V_{IO} and can detect CAN bus activity when V_{IO} is above switch-off undervoltage detection voltage $V_{\text{uvd(swoff)}}$ (even if V_{IO} is the only available supply voltage).

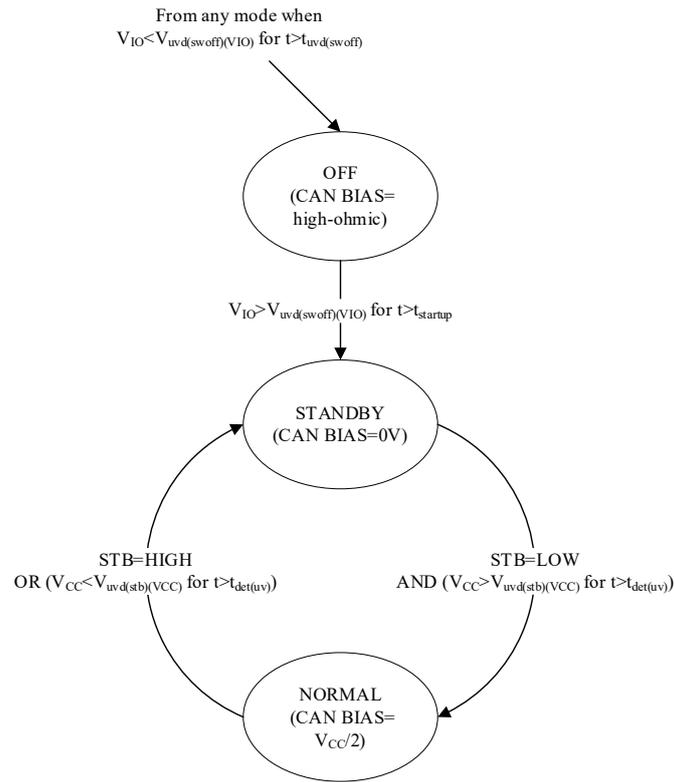
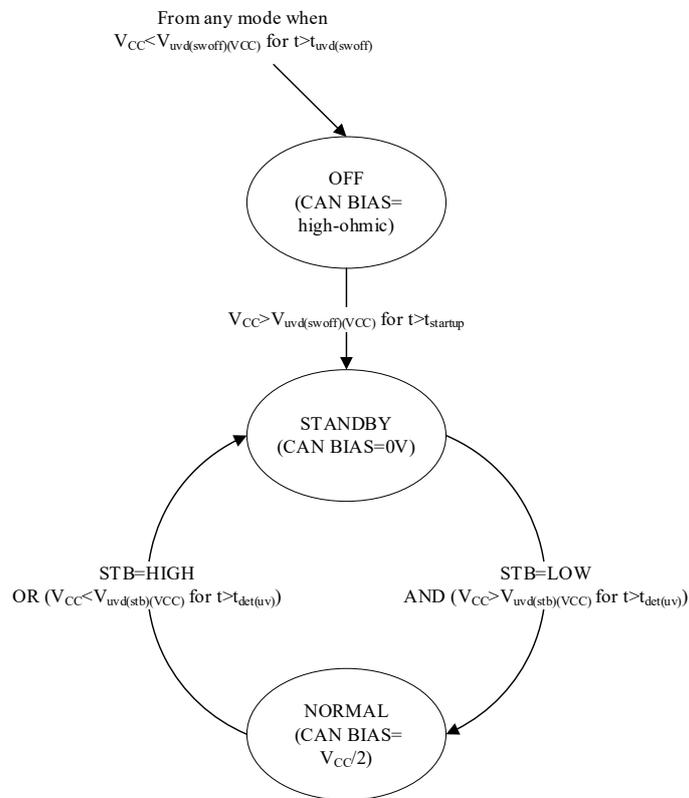
4.3 Normal mode

A LOW level on pin STB selects Normal mode, provided the supply voltage on pin VCC is above the standby undervoltage detection threshold, $V_{\text{uvd(std)}}$.

In this mode, the transceiver can transmit and receive data via bus lines CANH and CANL. Pin TXD must be HIGH at least once in Normal Mode before transmission can begin. The differential receiver converts the analog data on the bus lines into digital data on pin RXD. The slopes of the output signals on the bus lines are controlled internally and are optimized in a way that guarantees the lowest possible EME. In order to support high bit rates, especially in CAN FD systems, the Signal Improvement function largely eliminates topology-related reflections and impedance mismatches. In recessive state, the output voltage on the bus pins is $V_{\text{CC}}/2$.

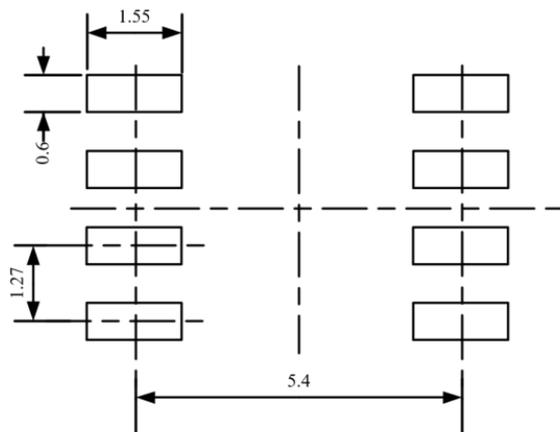
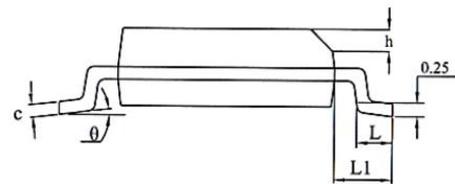
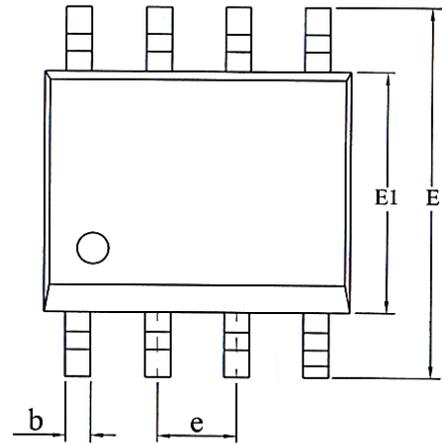
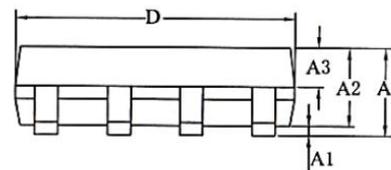
4.4 Operating modes and gap-free operation

Gap-free operation guarantees defined behavior at all voltage levels. Supply voltage-to-operating mode mapping is detailed in Figure 10 and in the state diagrams (Figure 8 and Figure 9)


Figure 8 SIT1044AQ/3 state diagram

Figure 9 SIT1044AQ state diagram

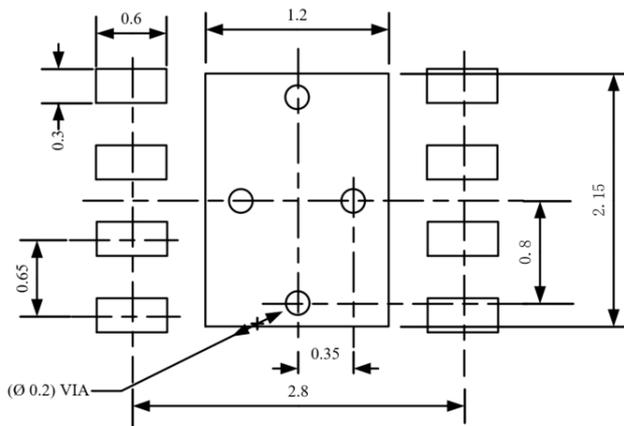
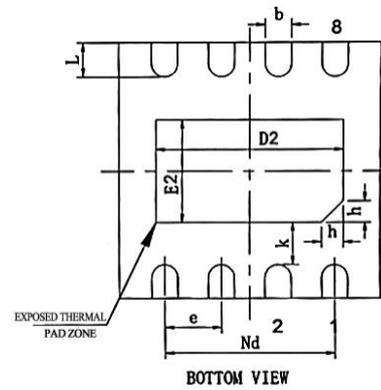
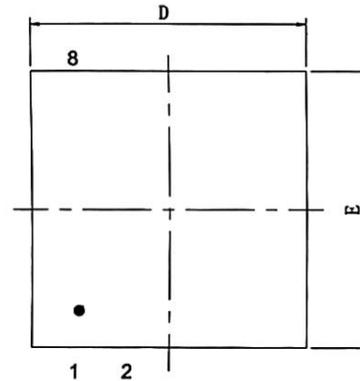
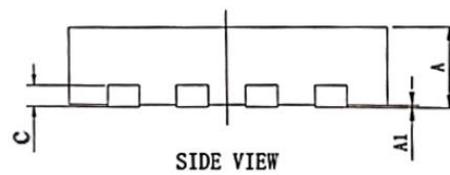
SOP8 DIMENSIONS
package size

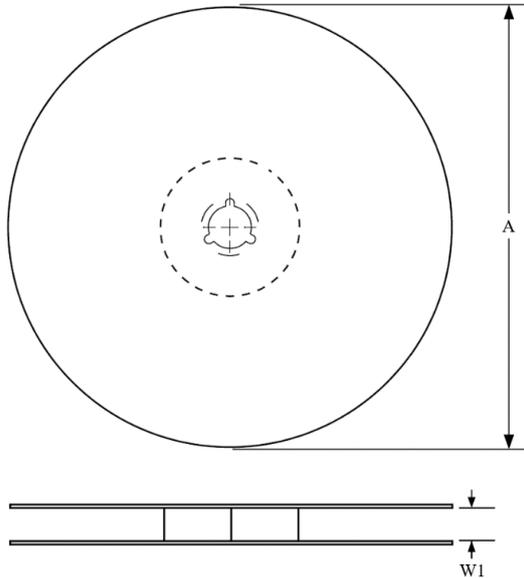
Symbol	Min./mm	Typ./mm	Max./mm
A	-	-	1.75
A1	0.10	-	0.225
A2	1.30	1.40	1.50
A3	0.60	0.65	0.70
b	0.39	-	0.47
D	4.80	4.90	5.00
E	5.80	6.00	6.20
E1	3.80	3.90	4.00
e	1.27BSC		
L	0.50	-	0.80
L1	1.05REF		
c	0.20	-	0.24
θ	0°	-	8°


LAND PATTERN EXAMPLE (Unit: mm)


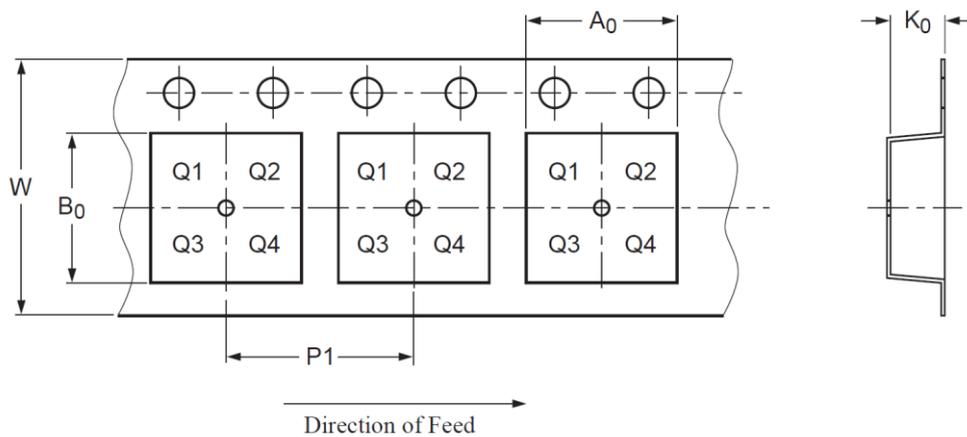
DFN3*3-8 DIMENSIONS
Package size

Symbol	Min./mm	Typ./mm	Max./mm
A	0.70	0.75	0.80
A1	0	0.02	0.05
A3	0.203 REF		
D	2.90	3.00	3.10
E	2.90	3.00	3.10
D2	2.05	2.15	2.25
Nd	1.95BSC		
E2	1.10	1.20	1.30
b	0.25	0.30	0.35
e	0.65BSC		
k	0.50REF		
L	0.35	0.40	0.45
h	0.20	0.25	0.30


LAND PATTERN EXAMPLE (Unit: mm)


TAPE AND REEL INFORMATION


A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers



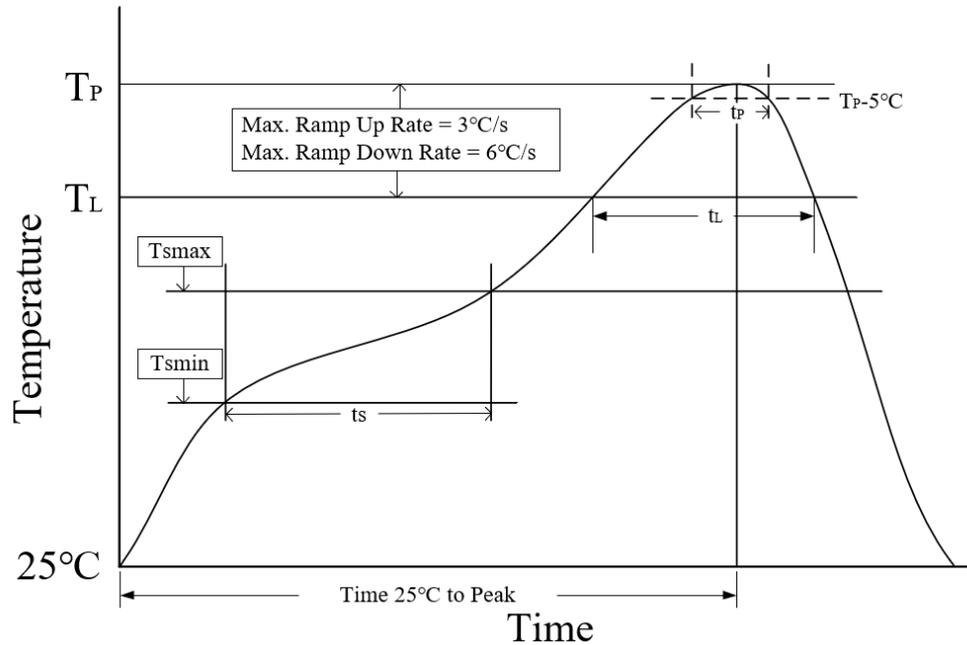
PIN1 is in quadrant 1

Package Type	Reel Diameter A (mm)	Tape Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)
SOP8	330±1	12.4	6.60±0.1	5.30±0.10	1.90±0.1	8.00±0.1	12.00±0.1
DFN3*3-8	329±1	12.4	3.30±0.1	3.30±0.1	1.10±0.1	8.00±0.1	12.00±0.3

ORDERING INFORMATION

Type number	Package	MSL	Packing
SIT1044AQT/3	SOP8	MSL3	Tape and reel
SIT1044AQT	SOP8	MSL3	Tape and reel
SIT1044AQTK/3	DFN3*3-8	MSL1	Tape and reel
SIT1044AQTK	DFN3*3-8	MSL1	Tape and reel

SOP8 is packed with 2500 pieces/disc in braided packaging; Leadless DFN3*3-8 is packed with 6000 pieces/disc in braided packaging.

REFLOW SOLDERING


Parameter	Lead-free soldering conditions
Ave ramp up rate (T_L to T_P)	$3^\circ\text{C/second max}$
Preheat time t_s ($T_{smin}=150^\circ\text{C}$ to $T_{smax}=200^\circ\text{C}$)	60-120 seconds
Melting time t_L ($T_L=217^\circ\text{C}$)	60-150 seconds
Peak temp T_P	$260-265^\circ\text{C}$
5°C below peak temperature t_p	30 seconds
Ave cooling rate (T_P to T_L)	$6^\circ\text{C/second max}$
Normal temperature 25°C to peak temperature T_P time	8 minutes max

Important statement

SIT reserves the right to change the above-mentioned information without prior notice.

REVISION HISTORY

Version number	Data sheet status	Revision date
V1.0	Initial version.	April 2025
V1.1	Updated the version of ISO11898; Updated the test condition of $V_{O(rec)}$ in standby mode; Added the parameters of $\Delta t_{bit(bus)}$, Δt_{rec} , $\Delta t_{bit(RXD)}$; Added the MSL.	June 2025